

Abstracts

A New Self-Calibrating Transistor Test Fixture

R.Q. Lane and G.L. McCollum. "A New Self-Calibrating Transistor Test Fixture." 1979 MTT-S International Microwave Symposium Digest 79.1 (1979 [MWSYM]): 99-101.

The design of a test fixture for strip line microwave transistors, accommodating precision coaxial calibration standards, is described. A wide variety of package styles may be measured without disturbing the initial calibration. Test data to 16 GHz is shown.

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